

Notice of References Cited	Application/Control No. 10/532,510		Applicant(s)/Patent Under Reexamination LEE, SEUNG JAE	
	Examiner Jonathan J. Liu		Art Unit 3673	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2,639,206 A	05-1953	BUTLER GEORGE V	5/621
*	B	US-3,081,085 A	03-1963	DE GIROLAMO ROBERT	482/144
*	C	US-3,561,022 A	02-1971		5/657
*	D	US-3,568,669 A	03-1971	Stites, Joseph D.	606/244
*	E	US-4,672,697 A	06-1987	Schurch, Ernesto	5/610
*	F	US-5,125,884 A	06-1992	Weber et al.	482/145
*	G	US-5,571,057 A	11-1996	Ayers, Margaret E.	463/36
*	H	US-5,638,826 A	06-1997	Wolpaw et al.	600/544
*	I	US-5,772,508 A	06-1998	Sugita et al.	463/36
*	J	US-5,967,956 A	10-1999	Teeter, Roger C.	482/144
*	K	US-6,167,298 A	12-2000	Levin, Richard B.	600/545
*	L	US-2003/0145383 A1	08-2003	Schwaegerle, Gary G.	5/610
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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